

## DS14C232 Low Power +5V Powered TIA/EIA-232 Dual Driver/Receiver General Description Features

The DS14C232 is a low power dual driver/receiver featuring an onboard DC to DC converter, eliminating the need for  $\pm$ 12V power supplies. The device only requires a +5V power supply. I<sub>CC</sub> is specified at 3.0 mA maximum, making the device ideal for battery and power conscious applications. The drivers' slew rate is set internally and the receivers feature internal noise filtering, eliminating the need for external slew rate and filter capacitors. The device is designed to interface data terminal equipment (DTE) with data circuit-terminating equipment (DCE). The driver inputs and receiver outputs are TTL and CMOS compatible. DS14C232C driver outputs and receiver inputs meet TIA/EIA-232-E (RS-232) and CCITT V.28 standards.

16

15

V<sub>CC</sub>

GND

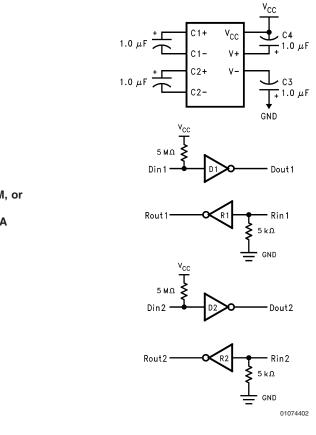
Dout 1

Rin1

- Pin compatible with industry standard MAX232, LT1081, ICL232 and TSC232
- Single +5V power supply
- Low power—I<sub>CC</sub> 3.0 mA maximum
- DS14C232C meets TIA/EIA-232-E (RS-232) and CCITT V.28 standards
- CMOS technology
- Receiver Noise Filter
- Package efficiency—2 drivers and 2 receivers
- Available in Plastic DIP, Narrow and Wide SOIC packages
- TIA/EIA-232 compatible extended temperature range option:

DS14C232T -40°C to +85°C DS14C232E/J: -55°C to +125°C

## **Functional Diagram**



1, Т

#### 

**Connection Diagram** 

C1+

٧+

 $C_{2}-$ 5 12 Rout1 V-6 11 – Din 1 Dout2 · 10 -Din2 Rin2 Rout2 8 01074401 Order Number DS14C232CN, DS14C232CM, or DS14C232TM See NS Package Number N16E, or M16A

## Absolute Maximum Ratings (Note 1)

Specifications for the 883 version of this product are listed separately on the following pages.

Supply Voltage, $V_{CC}$	-0.3V to 6V
V <sup>+</sup> Pin	$(V_{CC} - 0.3)V$ to +14V
V <sup>-</sup> Pin	+0.3V to -14V
Driver Input Voltage	–0.3V to (V <sub>CC</sub> + 0.3V)
Driver Output Voltage	$(V^+ + 0.3V)$ to $(V^$
	0.3V)
Receiver Input Voltage	±25V
Receiver Output Voltage	–0.3V to (V <sub>CC</sub> + 0.3V)
Junction Temperature	+150°C
Maximum Package Power	Dissipation @ 25°C
(Note 6)	
N Package	1698 mW
M Package	1156 mW
Short Circuit Duration,	
D <sub>OUT</sub>	Continuous

Storage Temp. Range	–65°C to +150°C
Lead Temp. (Soldering, 4	
sec.)	+260°C
ESD Rating	
(HBM, 1.5 kΩ, 100 pF)	≥ 2.5 kV

# Recommended Operating Conditions

	Min	Max	Units	
Supply Voltage, $V_{CC}$	4.5	5.5	V	
Operating Free Air Temp.				
(T <sub>A</sub> )				
DS14C232C	0	+70	°C	
DS14C232T	-40	+85	°C	

## Electrical Characteristics (Note 2)

Over recommended operating conditions, unless otherwise specified

Symbol	Parameter	Condition	ns	Min	Тур	Max	Units
DC TO	DC CONVERTER CHARACTERI	STICS			•		
V <sup>+</sup>	Positive Power Supply	$R_L = 3 k\Omega$ , C1–C4 = 1.0 μF	F, D <sub>IN</sub> = 0.8V		9.0		V
V-	Negative Power Supply	$R_L = 3 k\Omega$ , C1–C4 = 1.0 μF	<sup>-</sup> , D <sub>IN</sub> = 2.0V		-8.5		V
I <sub>CC</sub>	Supply (V <sub>CC</sub> ) Current	No Load			1.0	3.0	mA
DRIVER	CHARACTERISTICS			•	•		
V <sub>IH</sub>	High Level Input Voltage			2		V <sub>CC</sub>	V
V <sub>IL</sub>	Low Level Input Voltage			GND		0.8	V
I <sub>IH</sub>	High Level Input Current	$V_{IN} \ge 2.0V$		-10		+10	μA
I	Low Level Input Current	$V_{IN} \le 0.8V$		-10		+10	μA
V <sub>OH</sub>	High Level Output Voltage	$R_L = 3 k\Omega$		5.0	8.0		V
V <sub>OL</sub>	Low Level Output Voltage	$R_L = 3 k\Omega$			-7.0	-5.0	V
I <sub>OS+</sub>	Output High Short Circuit Current	$V_{O} = 0V, V_{IN} = 0.8V$	(Note 3)	-30	-15	-5.0	mA
I <sub>OS-</sub>	Output Low Short Circuit Current	$V_{O} = 0V, V_{IN} = 2V$		5.0	11	30	mA
Ro	Output Resistance	$-2V \le V_O \le +2V,$		300			Ω
		$V_{CC} = 0V = GND$					
RECEIV	ER CHARACTERISTICS			•	•		
$V_{TH}$	Input High Threshold Voltage	$V_{\rm CC} = 5.0 V$			1.9	2.4	V
		V <sub>CC</sub> = 5.0V ±10%			1.9	2.6	V
$V_{TL}$	Input Low Threshold Voltage			0.8	1.5		V
V <sub>HY</sub>	Hysteresis			0.2	0.4	1.0	V
R <sub>IN</sub>	Input Resistance		-15V ≤ V <sub>IN</sub> ≤ +15V	3.0	4.7	7.0	kΩ
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = +15V		+2.14	+3.75	+5.0	mA
		$V_{IN} = +3V$		+0.43	+0.64	+1.0	mA
		$V_{IN} = -3V$		-1.0	-0.64	-0.43	mA
		V <sub>IN</sub> = -15V		-5.0	-3.75	-2.14	mA
V <sub>OH</sub>	High Level Output Voltage	$V_{IN} = -3V, I_{O} = -3.2 \text{ mA}$		3.5	4.5		V

## Electrical Characteristics (Note 2) (Continued)

Over recommended operating conditions, unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Units
RECEIV	ER CHARACTERISTICS					
		$V_{IN} = -3V, I_O = -20 \ \mu A$	4.0	4.9		V
V <sub>OL</sub>	Low Level Output Voltage	$V_{IN} = +3V, I_{O} = +3.2 \text{ mA}$		0.15	0.4	V

## **Switching Characteristics**

Over recommended operating conditions, unless otherwise specified.

Symbol	Parameter	Condition	S	Min	Тур	Max	Units
DRIVER	CHARACTERISTICS			•			
t <sub>PLH</sub>	Propagation Delay Low to High	$R_L = 3 k\Omega$ $C_L = 50 pF$	Figure 1 and		1.0	4.0	μs
t <sub>PHL</sub>	Propagation Delay High to Low		Figure 2		1.0	4.0	μs
t <sub>sk</sub>	Skew It <sub>PLH</sub> – t <sub>PHL</sub> I				0.1	1.0	μs
SR1	Output Slew Rate	$R_{L} = 3 k\Omega$ to 7 k $\Omega$ , $C_{L} = 50$ pF	(Note 7)	4.0		30	V/µs
SR2	Output Slew Rate	$R_{L} = 3 k\Omega, C_{L} = 2500 pF$			4.5		V/µs
RECEIVE	R CHARACTERISTICS						
t <sub>PLH</sub>	Propagation Delay Low to High	Input Pulse Width > 10 μs			2.9	6.5	μs
t <sub>PHL</sub>	Propagation Delay High to Low	C <sub>L</sub> = 50 pF			2.5	6.5	μs
t <sub>sk</sub>	Skew It <sub>PLH</sub> – t <sub>PHL</sub> I	(Figures 3, 4)			0.4	2.0	μs
t <sub>nw</sub>	Noise Pulse Width Rejected	(Figures 3, 4)			0.7	0.5	μs

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" specify conditions for device operation.

Note 2: Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground unless otherwise specified.

**Note 3:** IOS<sub>+</sub> and IOS\_ values are for one output at a time. If more than one output is shorted simultaneously, the device power dissipation may be exceeded. **Note 4:** Receiver AC input waveform for test purposes:  $t_r = t_f = 200$  ns,  $V_{IL} = -3V$ , f = 30 kHz.

**Note 5:** All typicals are given for  $V_{CC} = 5.0V$ .

Note 6: Ratings apply to ambient temperature at +25°C. Above this temperature derate: N Package 15.6 mW/°C, and M Package 10.6 mW/°C.

**Note 7:** Slew rate is defined as  $\Delta V/\Delta t$ , measured between ±3V level.

## Absolute Maximum Ratings (Note 1)

For complete Military Product Specifications, refer to the appropriate SMD or MDS.

Supply Voltage, V <sub>CC</sub>	–0.3V to 6V
V <sup>+</sup> Pin	$(V_{CC} - 0.3)V$ to +14V
V <sup>-</sup> Pin	+0.3V to -14V
Driver Input Voltage	–0.3V to (V <sub>CC</sub> + 0.3V)
Driver Output Voltage	$(V^+ + 0.3V)$ to $(V^ 0.3V)$
Receiver Input Voltage	±25V
Receiver Output Voltage	–0.3V to (V <sub>CC</sub> + 0.3V)
Maximum Package Power Dise	sipation @ 25°C (Note 8)
J Package	1520 mW
E Package	2000 mW
Short Circuit Duration, $D_{OUT}$	Continuous

Storage Temp. Range	−65°C to +150°C
Lead Temp. (Soldering, 4	
sec.)	+260°C
ESD Rating	
(HMB, 1.5 kΩ, 100 pF)	≥ 2.5 kV

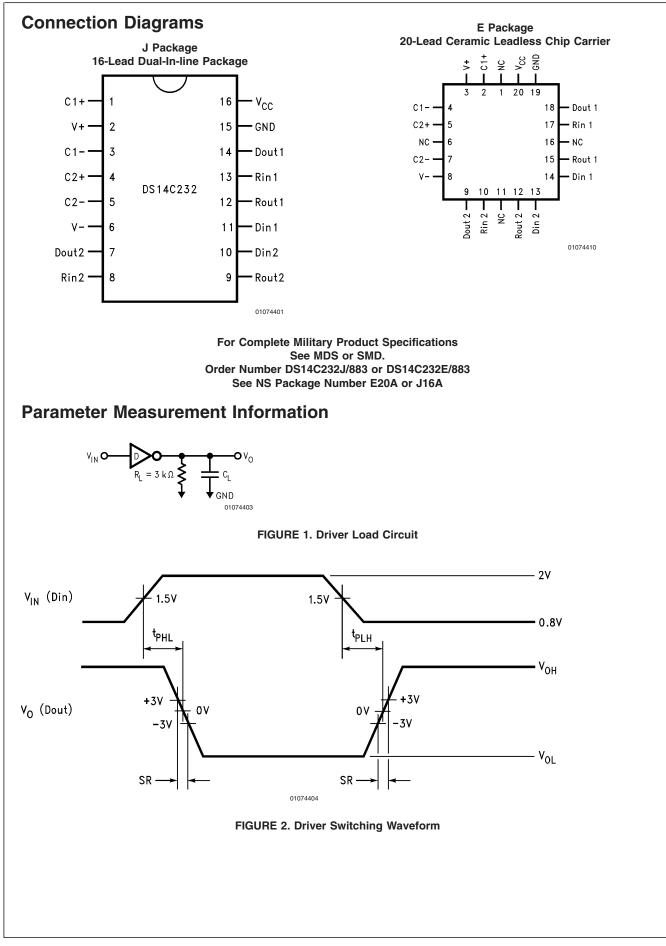
## Recommended Operating Conditions

	Min	Max	Units
Supply Voltage, V <sub>CC</sub>	4.5	5.5	V
Operating Free Air Temp. (T <sub>A</sub> )			
DS14C232E/J	-55	+125	°C

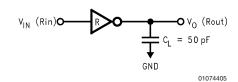
Symbol	Parameter	Conditions		Min	Max	Units
DEVICE	CHARACTERISTICS (C1–C4 = 1.0 µl	F)		1		
I <sub>cc</sub>	Supply (V <sub>CC</sub> ) Current	No Load			8.0	mA
DRIVER	CHARACTERISTICS					
V <sub>IH</sub>	High Level Input Voltage			2		V
V <sub>IL</sub>	Low Level Input Voltage				0.8	V
I <sub>IH</sub>	High Level Input Current	$V_{IN} \ge 2.0V$			100	μA
I <sub>IL</sub>	Low Level Input Current	$V_{IN} = 0V$			100	μA
V <sub>OH</sub>	High Level Output Voltage	$R_{L} = 3 k\Omega$		5.0		V
V <sub>OL</sub>	Low Level Output Voltage	$R_{L} = 3 k\Omega$			-5.0	V
I <sub>OS+</sub>	Output High Short Circuit Current	$V_{O} = 0V$	(Note 3)	-25		mA
I <sub>OS-</sub>	Output Low Short Circuit Current	$V_{O} = 0V$	1		25	mA
Ro	Output Resistance	$-2V \le V_O \le +2V, \ T_A = 25^{\circ}C,$	•	300		Ω
		$V_{CC} = 0V = GND$				
RECEIVE	ER CHARACTERISTICS (C1–C4 = 1.0	) µF)				
V <sub>TH</sub>	Input High Threshold Voltage				3.0	V
V <sub>TL</sub>	Input Low Threshold Voltage			0.2		V
V <sub>HY</sub>	Hysteresis	$T_{A} = 25^{\circ}C, +125^{\circ}C$		0.1	1.0	V
		$T_A = -55^{\circ}C$		0.05	1.0	V
R <sub>IN</sub>	Input Resistance	$V_{IN} = \pm 3V$ and $\pm 15V$ , $T_A = 25^{\circ}C$		3.0	7.0	kΩ
V <sub>он</sub>	High Level Output Voltage	$I_{O} = -3.2 \text{ mA}$		3.5		V
		$I_{O} = -20 \ \mu A$		4.0		V
V <sub>OL</sub>	Low Level Output Voltage	I <sub>O</sub> = +3.2 mA			0.4	V
V <sub>OL</sub>	Low Level Output Voltage			4.0	0.4	

Symbol	Falametei	Conditions			Ινίαλ	Units
DRIVER C	HARACTERISTICS (C1–C4 = 1.0	μF)				
t <sub>PLH</sub>	Propagation Delay Low to High	$R_L = 3 k\Omega, C_L = 50 pF$	Figures 1, 2		4.0	μs
t <sub>PHL</sub>	Propagation Delay High to Low				4.0	μs
t <sub>sk</sub>	Skew It <sub>PLH</sub> – t <sub>PHL</sub> I				1.0	μs
SR1	Output Slew Rate	$R_L = 3 \text{ k}\Omega$ to 7 k $\Omega$ , $C_L = 2500 \text{ pF}$	(Note 7)	1.5	30	V/µs
RECEIVER	CHARACTERISTICS (C1–C4 = 1	l.0 μF)				
t <sub>PLH</sub>	Propagation Delay Low to High	Input Pulse Width > 10 µs			8.0	μs
t <sub>PHL</sub>	Propagation Delay High to Low	C <sub>L</sub> = 50 pF			8.0	μs
t <sub>sk</sub>	Skew It <sub>PLH</sub> – t <sub>PHL</sub> I	(Figures 3, 4)			2.0	μs

Note 8: Ratings apply to ambient temperature at +25°C. Above this temperature derate: J Package 12.2 mW/°C and E Package 13.3 mW/°C.



## Parameter Measurement Information (Continued)



#### FIGURE 3. Receiver Load Circuit

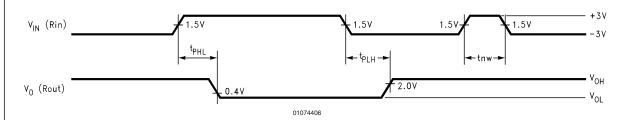


FIGURE 4. Receiver Propagation Delays and Noise Rejection (Note 4)

## **Pin Descriptions**

#### V<sub>cc</sub> (Pin 16)

Power supply pin for the device,  $+5V (\pm 10\%)$ .

#### V+ (Pin 2)

Positive supply for TIA/EIA-232-E drivers. Recommended external capacitor: C4-1.0  $\mu$ F (6.3V). Capacitor value should be larger than 1  $\mu$ F. This supply is not intended to be loaded externally.

#### V- (Pin 6)

Negative supply for TIA/EIA-232-E drivers. Recommended external capacitor: C3-1.0  $\mu$ F (16V). Capacitor value should be larger than 1  $\mu$ F. This supply is not intended to be loaded externally.

#### C1+, C1- (Pins 1, 3)

External capacitor connection pins. Recommended capacitor: 1.0  $\mu F$  (6.3V). Capacitor value should be larger than 1  $\mu F.$ 

#### C2+, C2- (Pins 4, 5)

External capacitor connection pins. Recommended capacitor: 1.0  $\mu F$  (16V). Capacitor value should be greater than 1  $\mu F.$ 

### D<sub>IN</sub>1, D<sub>IN</sub>2 (Pins 11, 10)

Driver input pins are TTL/CMOS compatible. Inputs of unused drivers may be left open, an internal active pull-up resistor (500 k $\Omega$  minimum, typically 5 M $\Omega$ ) pulls input HIGH. Output will be LOW for open inputs.

### D<sub>OUT</sub>1, D<sub>OUT</sub>2 (Pins 14, 7)

Driver output pins conform to TIA/EIA-232-E levels.

#### R<sub>IN</sub>1, R<sub>IN</sub>2 (Pins 13, 8)

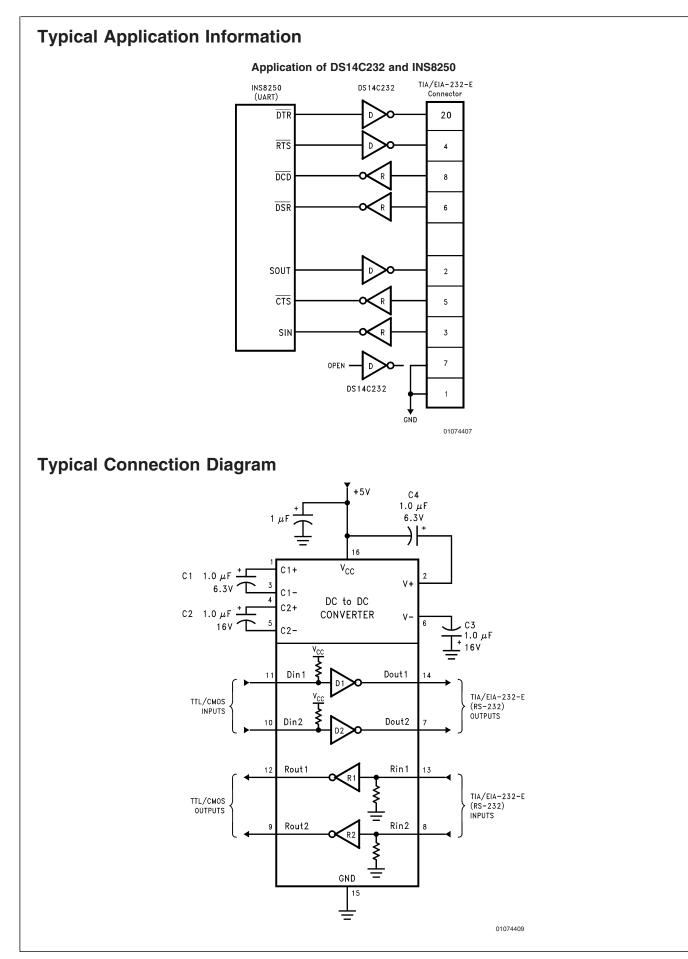
Receiver input pins accept TIA/EIA-232-E input voltages (±25V). Receivers feature a noise filter and guaranteed hysteresis of 100 mV. Unused receiver input pins may be left open. Internal input resistor 4.7 k $\Omega$  pulls input low, providing a failsafe high output.

#### R<sub>OUT</sub>1, R<sub>OUT</sub>2 (Pins 12, 9)

Receiver output pins are TTL/CMOS compatible. Receiver output HIGH voltage is specified for both CMOS and TTL load conditions.

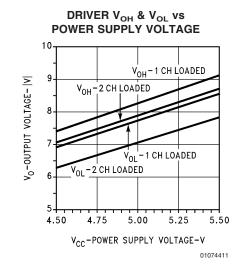
#### GND (Pin 15)

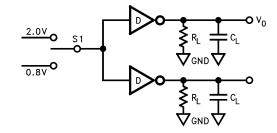
Ground Pin.



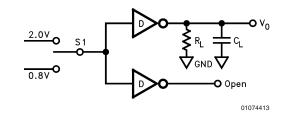


## **Typical Performance Characteristics**

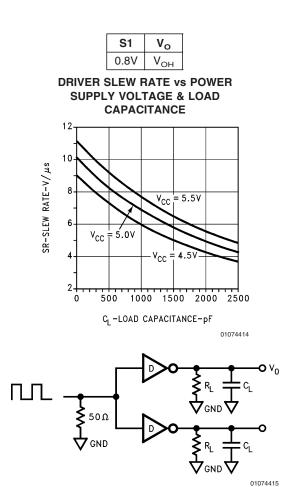




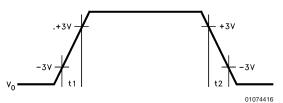
 $V_{CC}$  = 5.0V,  $R_L$  = 3 kΩ,  $C_L$  = 15 pF (includes jig and probe capacitance),  $C_P$  = 1  $\mu F$ 



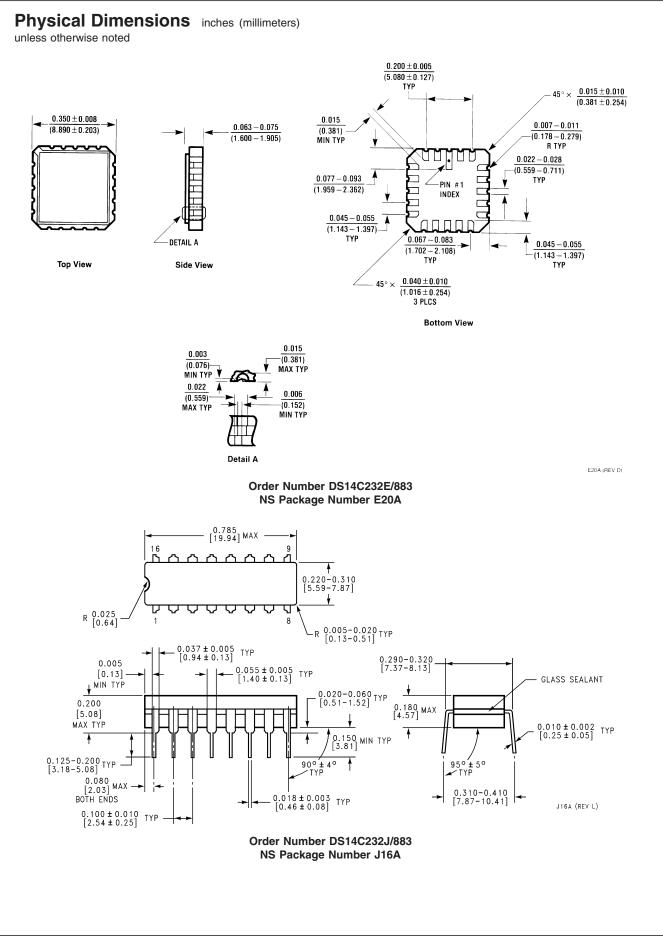
S1	٧o
2.0V	V <sub>OL</sub>

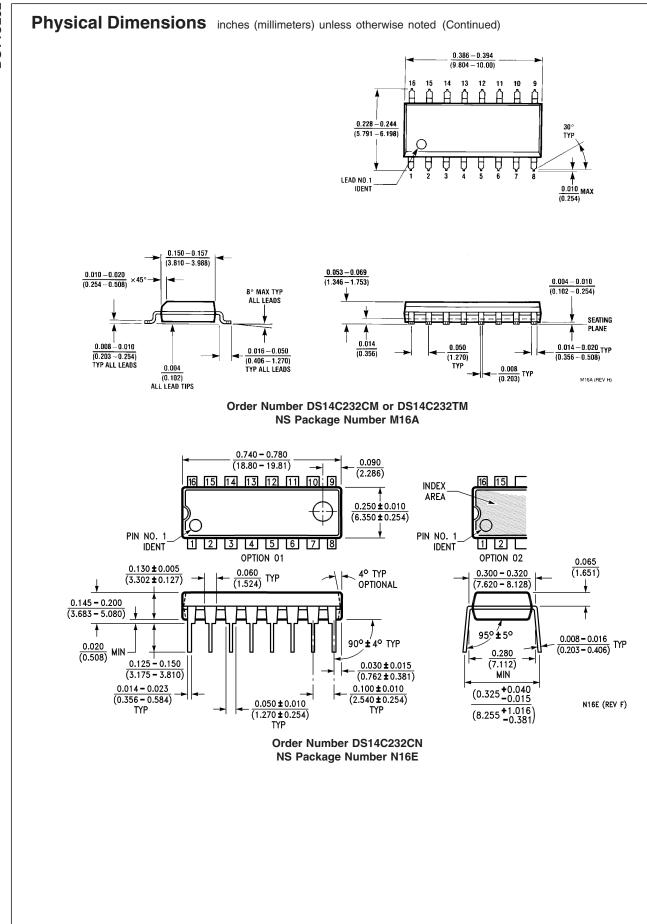


 $T_a = 25^{\circ}C, R_L = 5 \text{ k}\Omega, C_P = 1 \text{ }\mu\text{F}, f = 30 \text{ KHz}$ 



SR = 6V/t1 or 6V/t2, whichever is greater.





www.national.com

### Notes

#### LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **BANNED SUBSTANCE COMPLIANCE**

National Semiconductor certifies that the products and packing materials meet the provisions of the Customer Products Stewardship Specification (CSP-9-111C2) and the Banned Substances and Materials of Interest Specification (CSP-9-111S2) and contain no "Banned Substances" as defined in CSP-9-111S2.



www.national.com

National Semiconductor Americas Customer Support Center Email: new.feedback@nsc.com Tei: 1-800-272-9959 National Semiconductor Europe Customer Support Center Fax: +49 (0) 180-530 85 86 Email: europe.support@nsc.com Deutsch Tel: +44 (0) 69 9508 6208 English Tel: +44 (0) 870 24 0 2171 Français Tel: +33 (0) 1 41 91 8790 National Semiconductor Asia Pacific Customer Support Center Email: ap.support@nsc.com National Semiconductor Japan Customer Support Center Fax: 81-3-5639-7507 Email: jpn.feedback@nsc.com Tel: 81-3-5639-7560

National does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.